

**Notice of References Cited**

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10/690,686

Applicant(s)/Patent Under  
Reexamination  
AKKIRAJU ET AL.

Examiner

JOHN M. WINTER

Art Unit

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0187839 A1	10-2003	Zhang et al.	707/4
*	B	US-2003/0187841 A1	10-2003	Zhang et al.	707/4
*	C	US-2003/0217044 A1	11-2003	Zhang et al.	707/3
*	D	US-2003/0220962 A1	11-2003	Baskey et al.	709/203
*	E	US-2004/0064554 A1	04-2004	Kuno et al.	709/225
*	F	US-2004/0088713 A1	05-2004	Mylymaki et al.	719/315
*	G	US-2004/0111401 A1	06-2004	Chang et al.	707/003
*	H	US-2004/0122926 A1	06-2004	Moore et al.	709/223
*	I	US-2004/0213409 A1	10-2004	Murto et al.	380/258
*	J	US-2004/0220910 A1	11-2004	Zang et al.	707/003
*	K	US-2004/0230636 A1	11-2004	Masuoka et al.	708/800
*	L	US-2005/0044197 A1	02-2005	Lai, Ray Y.	709/223
*	M	US-2005/0091174 A1	04-2005	Akkiraju et al.	705/075

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
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	X					

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